# **MK1040VP LDMOS TRANSISTOR**

## 400W, 50V High Power RF LDMOS FETs

### **Description**

The MK1040VP is a 400-watt, high performance, internally matched LDMOS FET, designed for wide-band commercial and industrial applications with frequencies 0.5 to 1GHz

It is featured for high power and high ruggedness, suitable for Industrial, Scientific and Medical application, as well as UHF TV and Aerospace applications.

Typical performance(on 0.5-1GHz wideband test board with device soldered)
Signal: pulse CW, pulse width:100us, duty cycle:10%,Vgs=2.99V,Vds=50V,Idq=120mA

Freq(MHz)	Pin(dBm)	Psat(dBm)	Psat(W)	IDS(A)	Gain(dB)	η(%)
500	43.2	57.4	550	2.36	14.2	47%
600	41.2	57.8	603	1.89	16.6	64%
700	41.7	56.5	447	1.58	14.8	57%
800	40.7	56.1	407	1.89	15.4	43%
900	40.8	56.7	468	2.067	15.9	45%
1000	40.5	56	400	1.44	15.5	56%

Typical performance(on 915MHz narrow band test board with device soldered)

Vgs=2.97V,Vds=50V, Idq=100mA Frequency 915MHz

Signal	Pin(dBm)	Psat(dBm)	Psat(W)	IDS(A)	Gain(dB)	η(%)
10% 100us	39.5	57.3	537	1.8	17.8	60%
20% 100us	40.1	57.4	550	1.89	17.3	58.5%
20% 1ms	40.1	57	500	3.55	16.9	56.5%

### **Features**

- High Efficiency and Linear Gain Operations
- Integrated ESD Protection
- Excellent thermal stability, low HCI drift

- Large Positive and Negative Gate/Source Voltage Range for Improved Class C Operation
- Pb-free, RoHS-compliant

#### **Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
DrainSource Voltage	V <sub>DSS</sub>	+125	Vdc
GateSource Voltage	$V_{gs}$	-10 to +10	Vdc
Operating Voltage	$V_{DD}$	+55	Vdc
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	T <sub>c</sub>	+150	°C
Operating Junction Temperature	T,	+225	°C

**Table 2. Thermal Characteristics** 

Characteristic	Symbol	Value	Unit
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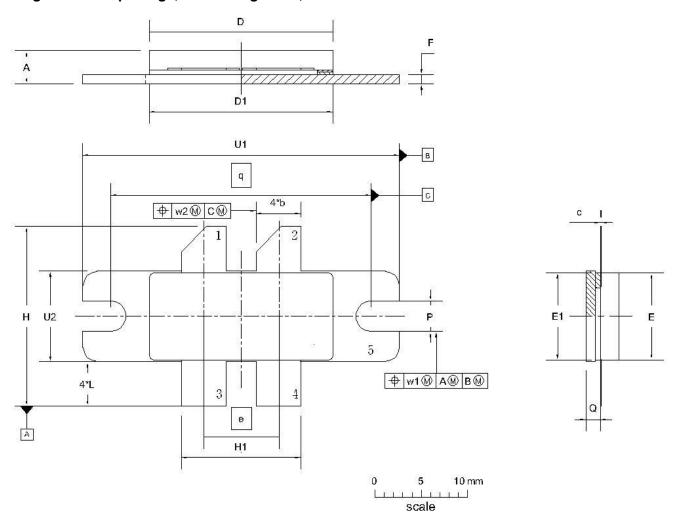
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Thermal Resistance, Junction to Case	Rejc	0	.35	°C/W			
T <sub>C</sub> = 85°C, T <sub>J</sub> =200°C, DC test	. 1000		0.33		0,77		
Table 3. ESD Protection Characteristics							
Test Methodology			Class				
Human Body Model (per JESD22A114)			Class 2				
Table 4. Electrical Characteristics (T <sub>A</sub> = 25 °C unless otherw	vise noted)						
Characteristic	Symbol	Min	Тур	Max	Unit		
DC Characteristics (per half section)							
Drain-Source Voltage	.,		125				
V <sub>GS</sub> =0, I <sub>DS</sub> =1.0mA	$V_{(BR)DSS}$		125		V		
Zero Gate Voltage Drain Leakage Current				1			
$(V_{DS} = 50V, V_{GS} = 0 V)$	I <sub>DSS</sub>				μΑ		
Zero Gate Voltage Drain Leakage Current				1	μА		
$(V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V})$	I <sub>DSS</sub>						
GateSource Leakage Current				4			
$(V_{GS} = 10 \text{ V}, V_{DS} = 0 \text{ V})$	I <sub>GSS</sub>			1	μА		
Gate Threshold Voltage	V (11)		0.05		.,,		
$(V_{DS} = 50V, I_D = 600 \mu A)$	$V_{GS}(th)$		2.65		V		
Gate Quiescent Voltage	.,		0.05				
$(V_{DD} = 50 \text{ V}, I_D = 100 \text{ mA}, \text{ Measured in Functional Test})$	$V_{GS(Q)}$		3.25		V		
Load Mismatch (In Innogration Test Fixture, 50 ohm system):	$V_{DD} = 50 \text{ Vdc}, I_{DQ} =$	= 100 mA, f = 9	15MHz, pulse	width:100us,	duty		
cycle:20%							
VSWR 10:1, at 500W Pulsed CW Output Power	No Device D	egradation					

# **MK1040VP LDMOS TRANSISTOR**

# **Package Outline**

## Flanged ceramic package; 2 mounting holes; 4 leads



UNIT	A	b	С	D	$D_1$	е	E	<b>E</b> <sub>1</sub>	F	Н	H1	L	р	Q	q	U <sub>1</sub>	$U_2$	$W_1$	W <sub>2</sub>
mm	4.72	3.94	0.15	20.02	19.96	0 00	9.50	9.53	1.14	19.94	12.83	5.33	3.38	1.70	27.94	34.16	9.91	0.25	0.51
mm	3.43	3.68	0.08	19.61	19.66	8.89	9.30	9.25	0.89	18.92	12.57	4.32	3.12	1.45	27.94	33.91	9.65	0.25	0.31
inches	0.186	0.155	0.006	0.788	0.786	0.25	0.374	0.375	0.045	0.785	0.505	0.210	0.133	0.067	1 100	1.345	0.390	0.04	0.02
inches	0.135	0.145	0.003	0.772	0.774	0.35	0.366	0.364	0.035	0.745	0.495	0.170	0.123	0.057	1.100	1.335	0.380	0.01	0.02

OUTLINE		REFERENCE		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	IOGGE DATE
PKG-B4E					03/12/2013

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## **Revision history**

Table 5. Document revision history

Date	Revision	Datasheet Status
2017/6/27	Rev 1.0	Preliminary Datasheet Creation

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